	Application No.	Applicant(s)
Notice of Allowability	10/709,630 Examiner	AMERICA ET AL.  Art Unit
	Lamine	Art office.
	Belur V Keshavan	2825
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. This communication is responsive to <u>05/18/2004</u> .		
2. The allowed claim(s) is/are <u>1-16</u> .		
3. The drawings filed on 18 May 2004 are accepted by the Examiner.		
<ul> <li>4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some* c) None of the: <ol> <li>Certified copies of the priority documents have been received.</li> <li>Certified copies of the priority documents have been received in Application No.</li> <li>Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).</li> </ol> </li> <li>* Certified copies not received:</li> </ul>		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.  THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.		
6. CORRECTED DRAWINGS ( as "replacement sheets") must be submitted.		
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review ( PTO-948) attached		
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date		
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).		
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s)  1. ☑ Notice of References Cited (PTO-892)  2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)  3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 05/18/2004 (2)  4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. Interview Summary Paper No./Mail Dat 08), 7. Examiner's Amendr	te

## **DETAILED ACTION**

## Allowable Subject Matter

Claims 1-16 are allowed.

## Examiner's Statement Of Reasons For Allowance

The following is an examiner's statement of reasons for allowance:

The invention is related to a method of implementing dual damascene processing and the limitations are found in claims 1-16. The limitations found in claims 1-16 are neither disclosed nor taught by the prior art of record, alone or in combination.

The primary reason for the allowability of claims 1-16 is the inclusion therein, in combination as currently claimed of the limitation of a method of implementing dual damascene processing comprising inter alia the following limitations:

forming a first hard mask layer over an interlevel dielectric layer; forming a second hard mask layer over the first hard mask layer and a third hard mask layer over the second hard mask layer; forming a trench pattern with in the third mask layer; implementing a first etch process to define a via pattern completely through the second hard mask layer and partially through the first hard mask layer; and implementing a second etch process to transfer the trench pattern and the via pattern into the interlevel dielectric layer. The prior art does not teach a method of implementing dual damascene processing with three hard mask layers wherein the etch process as recited in the claims includes only an initial partial etch through the first hard mask layer.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue

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fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for

Allowance."

**Contact Information** 

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Belur V Keshavan whose telephone number is 571-272-1894.

The examiner can normally be reached on 8-4:30 Monday to Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Matthew S Smith can be reached on 571-272-1907. The fax phone number for the

organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent

Application Information Retrieval (PAIR) system. Status information for published applications

may be obtained from either Private PAIR or Public PAIR. Status information for unpublished

applications is available through Private PAIR only. For more information about the PAIR

system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR

system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

November 22, 2004.

Belur V. Keshavan.

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SUPERVISORY PATENT EXAMINER

**TECHNOLOGY CENTER 2800**